Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/762,424	HAYASHI, MORIHIKO
Examiner	Art Unit

Kevin Mew

2616

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
370/328-329, 335 370/348, 431-432 370/437, 441-443, 458-459 (Text search only - see search history printout)	7/19/2007	KM